74ABT374AOctal D-type flip-flop; positive-edge trigger; 3-stateRev. 2 - 18 December 2012Product data sheet

1. General description

The 74ABT374A high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT374A is an 8-bit, edge triggered register coupled to eight 3-state output buffers. The two sections of the device are controlled independently by the clock input (CP) and output enable input (\overline{OE}) control gates.

The register is fully edge-triggered. The state of each D input, one set-up time before the LOW-to-HIGH clock transition, is transferred to the corresponding flip-flop's Q output.

The 3-state output buffers are designed to drive heavily loaded 3-state buses, MOS memories, or MOS microprocessors. The active LOW output enable $\overline{(OE)}$ controls all eight 3-state buffers independent of the clock operation.

When OE is LOW, the stored data appears at the outputs. When OE is HIGH, the outputs are in the high-impedance "OFF" state, which means they will neither drive nor load the bus.

2. Features and benefits

- 8-bit positive edge triggered register
- 3-state output buffers
- Power-on 3-state
- Power-on reset
- Output capability: +64 mA/–32 mA
- Latch-up protection exceeds 500 mA per JESD78B class II level A
- ESD protection:
 - HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V
- Live insertion/extraction permitted

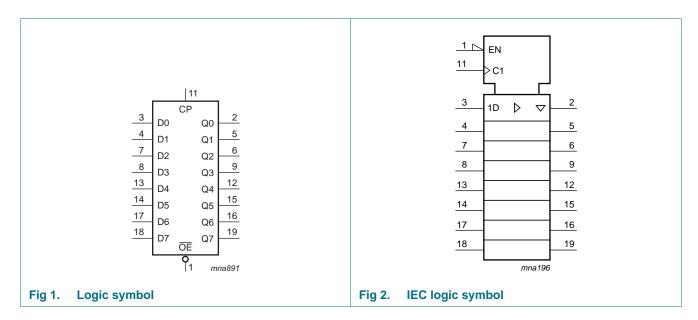


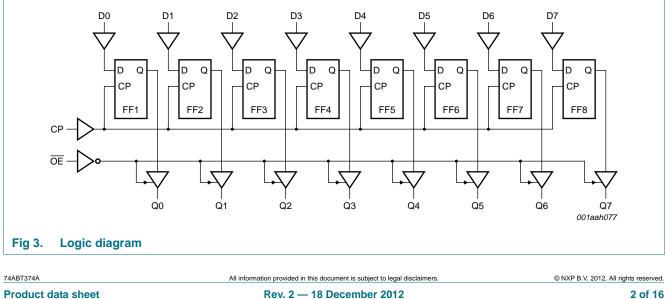
Octal D-type flip-flop; positive-edge trigger; 3-state

Ordering information 3.

Table 1. Ordering information										
Type number	Package									
	Temperature range	Name	Description	Version						
74ABT374AN	–40 °C to +85 °C	DIP20	plastic dual in-line package; 20 leads (300 mil)	SOT146-1						
74ABT374AD	–40 °C to +85 °C	SO20	plastic small outline package; 20 leads; body width 7.5 mm	SOT163-1						
74ABT374ADB	–40 °C to +85 °C	SSOP20	plastic shrink small outline package; 20 leads; body width 5.3 mm	SOT339-1						
74ABT374APW	–40 °C to +85 °C	TSSOP20	plastic thin shrink small outline package; 20 leads; body width 4.4 mm	SOT360-1						

Functional diagram 4.



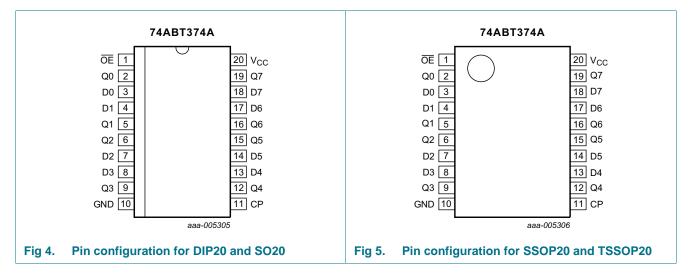


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5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2.Pin description

Symbol	Pin	Description
OE	1	3-state output enable input (active LOW)
D0, D1, D2, D3, D4, D5, D6, D7	3, 4, 7, 8, 13, 14, 17, 18	data input
GND	10	ground (0 V)
СР	11	clock pulse input (active rising edge)
Q0, Q1, Q2, Q3, Q4, Q5, Q6, Q7	2, 5, 6, 9, 12, 15, 16, 19	3-state flip-flop output
V _{CC}	20	supply voltage

6. Functional description

Table 3.Function table^[1]

Operating mode	Input			Internal	Output
	OE	СР	Dn	flip-flop	Qn
Load and read register	L	↑	I	L	L
	L	\uparrow	h	Н	Н
Load register and disable output	Н	\uparrow	Ι	L	Z
	Н	\uparrow	h	Н	Z

[1] H = HIGH voltage level

h = HIGH voltage level one setup time prior to the LOW-to-HIGH CP transition

L = LOW voltage level

I = LOW voltage level one setup time prior to the LOW-to-HIGH CP transition

Z = high-impedance OFF-state

 \uparrow = LOW-to-HIGH clock transition

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7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
-	i didifietei	Conditions	141111	Max	Onic
V _{CC}	supply voltage		-0.5	+7.0	V
VI	input voltage		<u>[1]</u> –1.2	+7.0	V
Vo	output voltage	output in OFF-state or HIGH-state	<u>[1]</u> –0.5	+5.5	V
I _{IK}	input clamping current	V ₁ < 0 V	-18	-	mA
Ι _{ΟΚ}	output clamping current	V _O < 0 V	-50	-	mA
lo	output current	output in LOW-state	-	128	mA
Tj	junction temperature		[2] _	150	°C
T _{stg}	storage temperature		-65	+150	°C

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

8. Recommended operating conditions

Table 5.Operating conditions

Voltages are referenced to GND (ground = 0 V).

•						
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		4.5	-	5.5	V
VI	input voltage		0	-	V _{CC}	V
V _{IH}	HIGH-level input voltage		2.0	-	-	V
V _{IL}	LOW-level input voltage		-	-	0.8	V
I _{OH}	HIGH-level output current		-32	-	-	mA
I _{OL}	LOW-level output current		-	-	64	mA
$\Delta t / \Delta V$	input transition rise and fall rate		0	-	10	ns/V
T _{amb}	ambient temperature	in free air	-40	-	+85	°C

9. Static characteristics

Table 6.	Static characteristics	i						
Symbol	Parameter	Conditions	25 °C			–40 °C t	o +85 °C	Unit
			Min	Тур	Max	Min	Max	
V _{IK}	input clamping voltage	V_{CC} = 4.5 V; I _{IK} = -18 mA	-1.2	-0.9	-	-1.2	-	V
V _{OH}	HIGH-level output	$V_{I} = V_{IL} \text{ or } V_{IH}$						
	voltage	V_{CC} = 4.5 V; I_{OH} = -3 mA	2.5	2.9	-	2.5	-	V
		V_{CC} = 5.0 V; I_{OH} = -3 mA	3.0	3.4	-	3.0	-	V
		V_{CC} = 4.5 V; I_{OH} = -32 mA	2.0	2.4	-	2.0	-	V
V _{OL}	LOW-level output voltage	$\label{eq:VCC} \begin{array}{l} V_{CC} = 4.5 \text{ V}; \text{ I}_{OL} = 64 \text{ mA}; \\ V_{I} = V_{IL} \text{ or } V_{IH} \end{array}$	-	0.42	0.55	-	0.55	V

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Symbol	Parameter	Conditions			25 °C		–40 °C t	o +85 °C	Unit
				Min	Тур	Max	Min	Max	
V _{OL(pu)}	power-up LOW-level output voltage	V_{CC} = 5.5 V; I _O = 1 mA; V _I = GND or V _{CC}	<u>[1]</u>	-	0.13	0.55	-	0.55	V
l _l	input leakage current	V_{CC} = 5.5 V; V_I = V_{CC} or GND		-	±0.01	±1.0	-	±1.0	μΑ
I _{OFF}	power-off leakage current	V_{CC} = 0 V; V_{I} or $V_{O} \leq 4.5$ V		-	±5.0	±100	-	±100	μΑ
I _{O(pu/pd)}	power-up/power-down output current	V_{CC} = 2.0 V; V_{O} = 0.5 V; V _I = GND or V _{CC} ; OE HIGH	[2]	-	±5.0	±50	-	±50	μΑ
l _{oz}	OFF-state output	V_{CC} = 5.5 V; V_I = V_{IL} or V_{IH}							
	current	V _O = 2.7 V		-	5.0	50	-	50	μΑ
		V _O = 0.5 V		-50	-5.0	-	-50	-	μΑ
I _{LO}	output leakage current	HIGH-state; $V_O = 5.5 V$; $V_{CC} = 5.5 V$; $V_I = GND \text{ or } V_{CC}$		-	5.0	50	-	50	μΑ
lo	output current	V_{CC} = 5.5 V; V_{O} = 2.5 V	[3]	-180	-100	-50	-180	-50	mA
I _{CC}	supply current	V_{CC} = 5.5 V; V_{I} = GND or V_{CC}							
		outputs HIGH-state		-	110	250	-	250	μΑ
		outputs LOW-state		-	24	30	-	30	mA
		outputs disabled		-	110	250	-	250	μΑ
ΔI_{CC}	additional supply current	per input pin; $V_{CC} = 5.5 V$; one input at 3.4 V; other inputs at V_{CC} or GND	<u>[4]</u>	-	0.5	1.5	-	1.5	mA
CI	input capacitance	$V_I = 0 V \text{ or } V_{CC}$		-	4	-	-	-	pF
Co	output capacitance	outputs disabled; $V_O = 0$ V or V_{CC}		-	7	-	-	-	pF

Table 6. Static characteristics ...continued

[1] For valid test results, data must not be loaded into the flip-flops (or latches) after applying the power.

[2] This parameter is valid for any V_{CC} between 0 V and 2.1 V, with a transition time of up to 10 ms. From V_{CC} = 2.1 V to V_{CC} = 5 V \pm 10 % a transition time of up to 100 μ s is permitted.

[3] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[4] This is the increase in supply current for each input at 3.4 V.

10. Dynamic characteristics

Table 7. Dynamic characteristics

GND = 0 V; for test circuit, see Figure 9.

Symbol	Parameter	Conditions	25 °C	; V _{CC} =	5.0 V		o +85 °C; V ± 0.5 V	Unit
			Min	Тур	Max	Min	Max	
f _{max}	maximum frequency	see Figure 6	200	300	-	200	-	MHz
t _{PLH}	LOW to HIGH propagation delay	CP to Qn; see Figure 6	1.7	3.4	4.5	1.7	5.1	ns
t _{PHL}	HIGH to LOW propagation delay	CP to Qn; see <u>Figure 6</u>	2.0	3.8	4.9	2.0	5.2	ns
t _{PZH}	OFF-state to HIGH propagation delay	OE to Qn; see Figure 8	1.2	3.5	4.5	1.2	5.4	ns

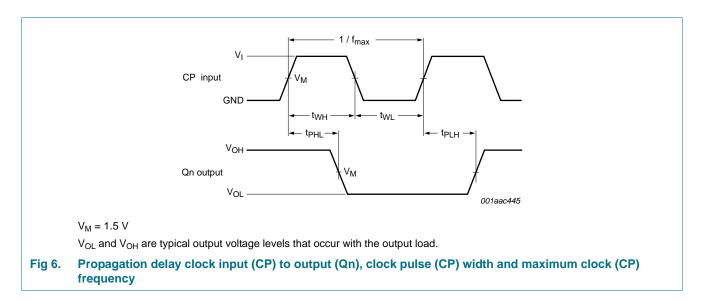
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Symbol	Parameter	Conditions	25 °	°C; \	V _{cc} =	5.0 V		o +85 °C; V ± 0.5 V	Unit
			Mir	n	Тур	Max	Min	Max	
t _{PZL}	OFF-state to LOW propagation delay	OE to Qn; see Figure 8	2.2	2	4.3	5.4	2.2	6.2	ns
t _{PHZ}	HIGH to OFF-state propagation delay	OE to Qn; see Figure 8	1.8	3	3.6	4.7	1.8	5.2	ns
t _{PLZ}	LOW to OFF-state propagation delay	OE to Qn; see Figure 8	1.5	5	3.0	4.1	1.5	4.3	ns
t _{su(H)}	set-up time HIGH	Dn to CP; see Figure 7	1.5	5	0.6	-	1.5	-	ns
t _{su(L)}	set-up time LOW	Dn to CP; see Figure 7	1.2	2	0.3	-	1.2	-	ns
t _{h(H)}	hold time HIGH	CP to Dn; see Figure 7	1.() .	-0.3	-	1.0	-	ns
t _{h(L)}	hold time LOW	CP to Dn; see Figure 7	1.() .	-0.5	-	1.0	-	ns
t _{WH}	pulse width HIGH	CP; see <u>Figure 6</u>	2.0)	0.8	-	2.0	-	ns
t _{WL}	pulse width LOW	CP; see Figure 6	2.8	3	1.0	-	2.8	-	ns

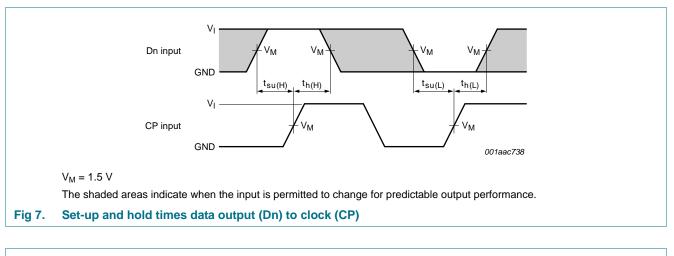
Table 7. Dynamic characteristics ... continued GND = 0 V: for test circuit, see Figure 9.

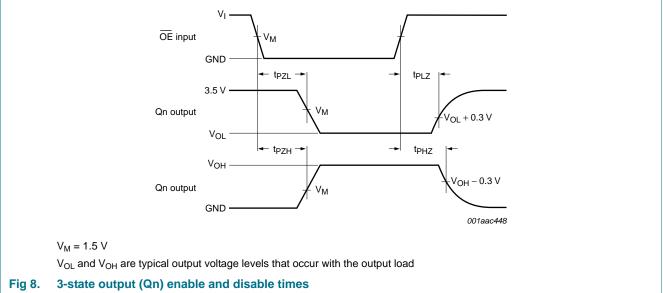
11. Waveforms



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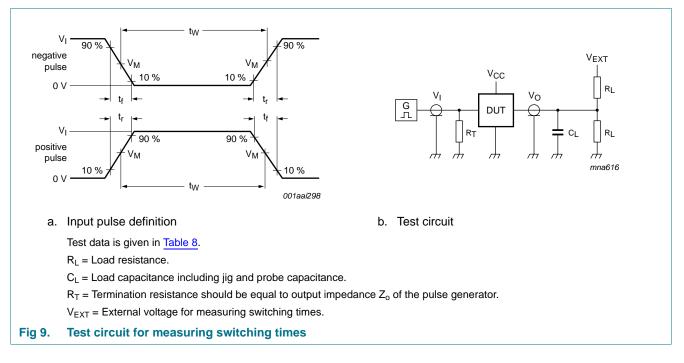


Table 8. Test data

Input			Load		V _{EXT}				
VI	fi	t _W	t _r , t _f	C _L R _L 1		t _{PHL} , t _{PLH}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}	
3.0 V	1 MHz	500 ns	\leq 2.5 ns	50 pF	500 Ω	open	open	7.0 V	

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12. Package outline

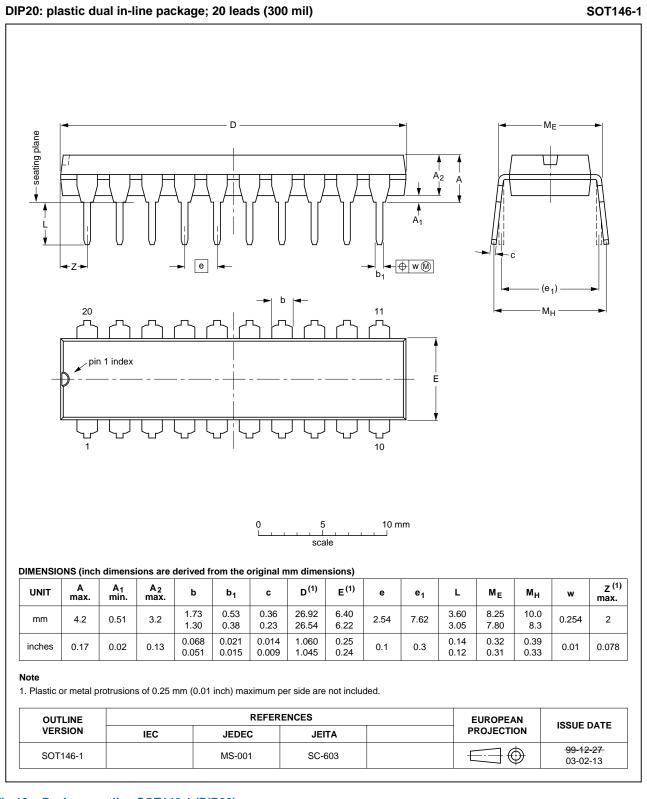


Fig 10. Package outline SOT146-1 (DIP20)

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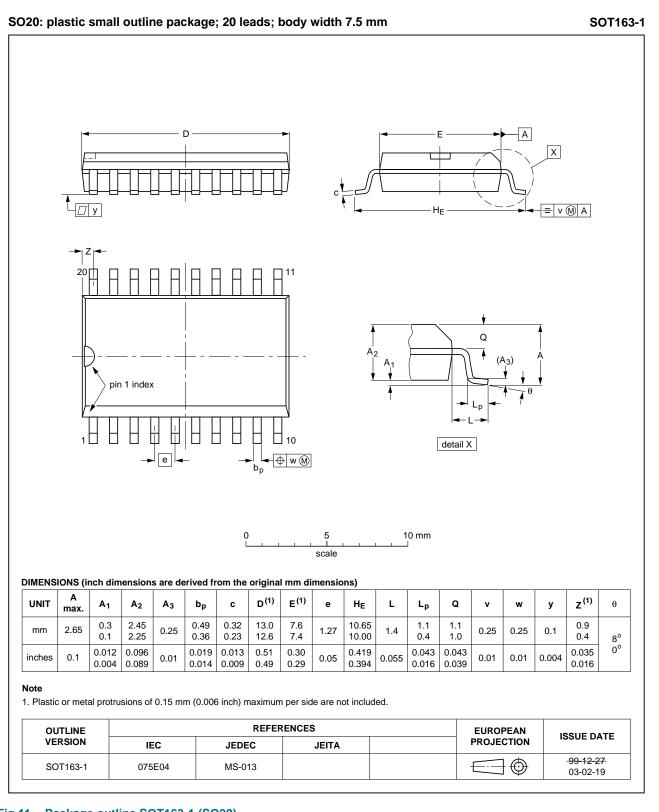


Fig 11. Package outline SOT163-1 (SO20)

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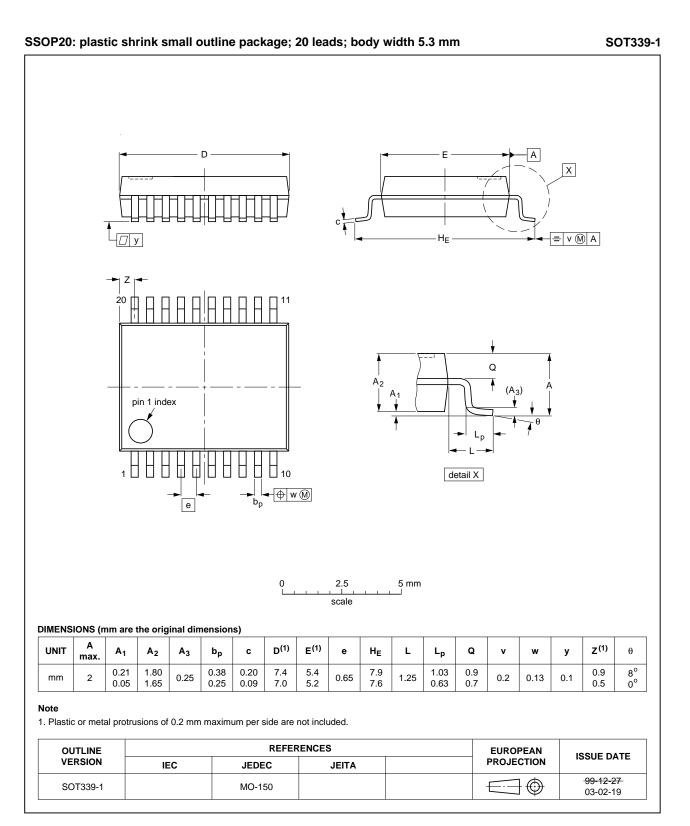


Fig 12. Package outline SOT339-1 (SSOP20)

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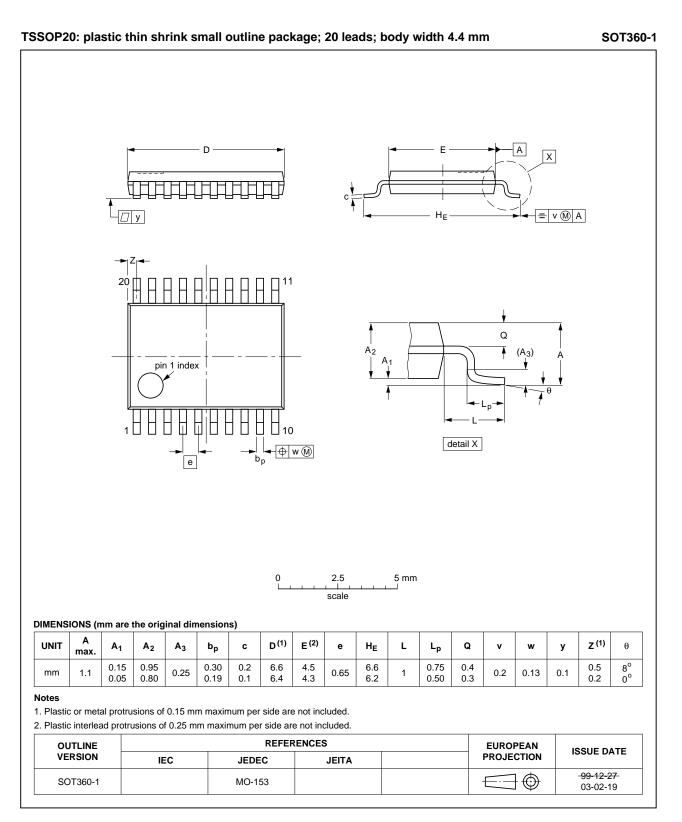


Fig 13. Package outline SOT360-1 (TSSOP20)

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13. Abbreviations

Table 9.	able 9. Abbreviations			
Acronym	Description			
BiCMOS	Bipolar Complementary Metal-Oxide Semiconductor			
DUT	Device Under Test			
ESD	ElectroStatic Discharge			
HBM	Human Body Model			
MM	Machine Model			

14. Revision history

Table 10.Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ABT374A v.2	20121218	Product data sheet	-	74ABT374A v.1
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. 			
	 Legal texts 	have been adapted to the	new company name whe	ere appropriate.
74ABT374A v.1	19950906	Product specification	-	-

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Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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